

# Search Notes



Application/Control No.

10/622,434

Examiner

Linh M. Nguyen

Applicant(s)/Patent under Reexamination

YAMAJI ET AL.

Art Unit

2816

## SEARCHED

Class	Subclass	Date	Examiner
327	101	11/22/05	LM
"	105	"	"
"	113	"	"
"	119	"	"
332	103	"	"
"	117	"	"
"	164	"	"
"	177	"	"

## INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

## SEARCH NOTES (INCLUDING SEARCH STRATEGY)

	DATE	EXMR
EAST TEXT Search	11/22/05	LM